PATENT NUMBER and ISSUE DATE

U.S. UTILITY Patent Application

À	APPL NUM	FILING DATE		SUBCLASS	GAU 2824	EXAMINER LEBEATRITT					
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	**APPLICANTS: Chavan Abhijeet; Logsdon James; Chilcott Dan; Christenson John; Speck Robert;										
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	**CONTINUING DATA VERIFIED: This appln claims benefit of 60/354,589 02/04/2002 MGC										
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1	** FOREIGN APPLICATIONS VERIFIED: No.										
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	Foreign priority ci			es K ESCI	ND -	ATTORNEY DOCKET NO					
	35 USC 119 conditions met										
	Verified and Acknowledged Examiners's intials TITLE: Process for a monolithically-integrated micromachined sensor and circuit										
			,			U.S.DEPT. OF COMM./PAT.& TM-PTO-436L(R	lev.				
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NOTICE OF ALL	OWANCE MAILED		CLAIMS ALLOWED						
		Assistant Examiner	Total Claims		Print Claim for O.G				
ISS	UE FEE			DRAWING					
Amount Due	Date Paid		Sheets Drwg.	Figs.Drwg.	Print Fig.				
	<u> </u>	Primary Examine	r						
TEF	RMINAL	PREPARED FOR ISSUE Application Examiner							
	DISCLAMER	WARNING: The information disclosed herein may be restricted. Unauthorized disclosure may be prohibited by the United States Code Title 35, Sections 122, 181 and 368, Possession outside the U.S. Patent & Trademark Office is restricted to authorized employees and contractors only.							
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